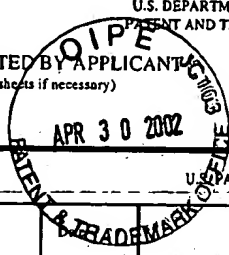


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U.S. PATENT DOCUMENTS							
*Examiner Initial	Document Number	Name	Class	Subclass	Filing Date If Appropriate		
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)			
<div style="font-family: cursive; font-size: 1.5em; margin-bottom: 10px;">Wle</div>	AR		S. Wolf, <i>Silicon Processing for the VLSI Era</i> , Volume 3 - The Submicron MOSFET, ©1995 Lattice Press, pages 330, 331, 366 and 367.
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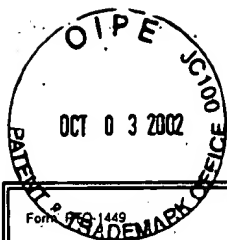
EXAMINER <div style="font-family: cursive; font-size: 1.2em; margin-top: 5px;">hanna schultz</div>	DATE CONSIDERED <div style="font-size: 1.2em; margin-top: 5px;">5/27/04</div>
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				GROUP 2813			
U.S. PATENT DOCUMENTS							
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
RL	AA	5,851,899	12/22/1998	Weigand			
RL	AB	5,880,007	03/09/1999	Varian et al.			
RL	AC	6,001,740	12/14/1999	Varian et al.			
RL	AD	6,124,183	09/26/2000	Karlsson et al.			
RL	AE	6,159,822	12/12/2000	Yang et al.			
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
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EXAMINER Hans Schutt				DATE CONSIDERED 5/22/04			
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				FILING DATE April 12, 2001	GROUP 2813
U.S. PATENT DOCUMENTS					
*Examiner Initial		Document Number	Date	Name	Filing Date If Appropriate
RR	AA	5,926,723	07/20/99	Wang	
RR	AB	6,420,749 B1	07/16/02	Divakaruni et al.	
RR	AC	6,177,324 B1	01/23/01	Song et al.	
RR	AD	6,429,081 B1	08/06/02	Doong et al.	
RR	AE	6,121,651	09/19/00	Furukawa et al.	
RR	AF	5,492,858	02/20/96	Bose et al.	
RR	AG	6,323,082 B1	11/27/01	Furukawa et al.	
RR	AH	6,156,620	12/05/00	Puchner et al.	
RR	AI	6,048,765	04/11/00	Wu	
RR	AJ	6,351,019 B1	02/26/02	DeBrosse et al.	
RR	AK	6,153,467	11/28/00	Wu	
FOREIGN PATENT DOCUMENTS					
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)					
	AQ		Wolf et al., "Silicon Processing for the VLSI Era" - Volume 1 - Process Technology - Second Edition, © 2000, 6 pages.		
	AR				
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EXAMINER		DATE CONSIDERED			
Hanna Schult		5/27/04			
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U.S. PATENT DOCUMENTS

*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
He	AA	6,236,079 B1	05/22/01	Nitayama et al.			
He	AB	6,294,422 B1	09/25/01	Sunouchi et al.			
He	AC	6,133,055	10/17/00	Yeh			
He	AD	6,353,242 B1	03/05/02	Watanabe et al.			
He	AE	6,037,671	03/14/00	Kepler et al.			
He	AF	6,028,784	02/22/00	Mori et al.			
He	AG	6,025,623	02/15/00	Sunouchi et al.			
He	AH	6,261,883 B1	07/17/01	Koubuchi et al.			
He	AI	6,403,484 B1	06/11/02	Lim et al.			
He	AJ	5,994,198	11/30/99	Hsu et al.			
He	AK	6,060,394	05/09/00	Wu			

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EXAMINER

Luan C. Tran

DATE CONSIDERED

5/24/01

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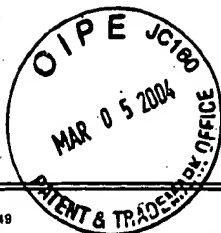
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				FILING DATE April 12, 2001		GROUP 2813	
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*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
RA	AA	6,312,997 B1	11/06/01	Tran			
RA	AB	6,411,555 B1	06/25/02	Tran			
RA	AC	5,892,707	04/06/99	Noble			
RA	AD	6,171,929 B1	01/09/01	Yang et al.			
RA	AE	6,391,756 B1	05/21/02	Pan et al.			
RA	AF	6,423,620 B2	07/23/02	Pan et al.			
RA	AG	6,297,129 B2	10/02/01	Tran et al.			
RA	AH	5,447,884	09/05/95	Fahey et al.			
RA	AI	5,851,900	12/22/98	Chu et al.			
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EXAMINER Hanna S. [Signature]				DATE CONSIDERED 5/27/04			
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U.S. PATENT DOCUMENTS							
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AB	AA	6,545,904 B2	4/8/2003	Tran			
AB	AB	6,492,693 B2	12/10/2002	Tran			
AC	AC	6,649,461 B1	11/18/2003	Lai et al.			
AD	AD	6,281,082 B1	8/28/2001	Chen et al.			
AE	AE	5,691,215	11/25/1997	Dai et al.			
AF	AF	6,261,914 B1	7/17/2001	Divakaruni et al.			
AG	AG	6,426,534 B1	7/30/2002	Look et al.			
AH	AH	2003/0020106 A1	1/30/2003	Tran			
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